

Silicon Carbide Power MOSFET C3M™ MOSFET Technology N-Channel Enhancement Mode

#### **Features**

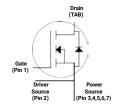
- 3<sup>rd</sup> generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q<sub>rr</sub>)
- Halogen free, RoHS compliant







TO-263-7L XL



Package Types: TO-263-7L XL PN's: C3M0045065J1

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#### **Applications**

- Datacenter and telecom power supplies
- EV battery chargers
- High voltage DC/DC converters
- Energy storage systems
- Solar inverters

#### **Benefits**

- · Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

### **Key Parameters**

Parameter	Symbol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V <sub>DS</sub>			650		T <sub>c</sub> = 25°C	
Maximum Gate - Source Voltage	V <sub>GS(max)</sub>	-8		+19	v	Transient	
Operational Gate-Source Voltage	V <sub>GS op</sub>		-4/15			Static	Note 1
DC Continuous Drain Current	I <sub>D</sub>			47	A	V <sub>GS</sub> = 15 V, T <sub>C</sub> = 25 °C, T <sub>J</sub> ≤150 °C	Fig. 19 Note 2
				31		$V_{GS} = 15 \text{ V}, T_{C} = 100 \text{ °C}, T_{J} \le 150 \text{ °C}$	
Pulsed Drain Current	I <sub>DM</sub>			132		$t_{Pmax}$ limited by $T_{jmax}$ $V_{GS} = 15V$ , $T_C = 25$ °C	Fig. 22
Power Dissipation	P <sub>D</sub>			147	w	$T_c = 25^{\circ}C, T_J = 150^{\circ}C$	Fig. 20
Operating Junction Temperature	T <sub>J</sub>			-40 to +175			
Case and Storage Temperature	$T_c$ , $T_{stg}$			-40 to 150	°C		
Solder Temperature	T <sub>L</sub>			260		According to JEDEC J-STD-020	

Note (1): Recommended turn-on gate voltage is 15V with  $\pm 5\%$  regulation tolerance, see Application Note PRD-04814 for additional details Note (2): Verified by design

# **Electrical Characteristics** ( $T_c = 25$ °C Unless Otherwise Specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Note
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	650				$V_{GS} = 0 \text{ V, I}_{D} = 100 \mu\text{A}$	
Gate Threshold Voltage	.,	1.8	2.6	3.6	V	$V_{DS} = V_{GS}$ , $I_{D} = 4.84 \text{ mA}$	Fig. 11
	V <sub>GS(th)</sub>		2.3			$V_{DS} = V_{GS}$ , $I_D = 4.84$ mA, $T_J = 150$ °C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		1	50	μА	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	
Gate-Source Leakage Current	I <sub>GSS</sub>		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
			45	60	- mΩ	$V_{GS} = 15 \text{ V}, I_D = 17.6 \text{ A}$	Fig. 4,
Drain-Source On-State Resistance	R <sub>DS(on)</sub>		54			$V_{GS} = 15 \text{ V}, I_D = 17.6 \text{ A}, T_J = 150 \text{ °C}$	5,6
			12		_	$V_{DS} = 20 \text{ V}, I_{DS} = 17.6 \text{ A}$	— Fig. 7
Transconductance	$g_{fs}$		11		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 17.6 A, T <sub>J</sub> = 150 °C	
Input Capacitance	C <sub>iss</sub>		1621				Fig. 17, 18
Output Capacitance	C <sub>oss</sub>		101			$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V to } 400 \text{ V}$ f = 1 MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>		8		pF	V <sub>AC</sub> = 25 mV	
Effective Output Capacitance (Energy Related)	C <sub>o(er)</sub>		126		. P'		Note: 2
Effective Output Capacitance (Time Related)	C <sub>o(tr)</sub>		178			$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V to } 400 \text{ V}$	Note: 2
C <sub>oss</sub> Stored Energy	E <sub>oss</sub>		10		μJ	V <sub>DS</sub> = 400 V, f = 1 MHz	Fig. 16
Turn-On Switching Energy (Body Diode)	E <sub>on</sub>		36			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_{D} = 17.6 \text{ A},$	Fig. 25
Turn-Off Switching Energy (Body Diode)	E <sub>OFF</sub>		7		μJ	$R_{G(ext)} = 2.5 \Omega$ , L = 99 $\mu$ H, $T_J = 25  ^{\circ}$ C FWD = Internal Body Diode of MOSFET	
Turn-On Delay Time	t <sub>d(on)</sub>		8				Fig. 26
Rise Time	t,		10			$V_{DD} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 17.6 \text{ A},$ $R_{G(ext)} = 2.5 \Omega, L = 99 \mu\text{H}$	
Turn-Off Delay Time	t <sub>d(off)</sub>		19		ns	Timing Relative to V <sub>DS</sub>	
Fall Time	t <sub>f</sub>		6			Inductive Load	
Internal Gate Resistance	R <sub>G(int)</sub>		3		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV	
Gate to Source Charge	$Q_{\rm gs}$		21				
Gate to Drain Charge	$Q_{\rm gd}$		16		nC	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 17.6 \text{ A}$	Fig. 12
Total Gate Charge	Q <sub>g</sub>		61			Per IEC60747-8-4 pg 21	

Note (2):  $C_{o(er)}$ , a lumped capacitance that gives same stored energy as coss while  $V_{DS}$  is rising from 0 to 400 V.  $C_{o(tr)}$ , a lumped capacitance that gives same charging time as coss while  $V_{DS}$  is rising from 0 to 400 V.

# **Reverse Diode Characteristics** (T<sub>c</sub> = 25 °C Unless Otherwise Specified)

Parameter	Symbol	Тур.	Max.	Unit	Test Conditions	Note	
Diode Forward Voltage	V	4.8		V	$V_{GS} = -4 \text{ V}, I_{SD} = 8.8 \text{ A}, T_{J} = 25 \text{ °C}$	Fig. 8, 9, 10	
	V <sub>SD</sub>	4.2		V	$V_{GS} = -4 \text{ V}, I_{SD} = 8.8 \text{ A}, T_{J} = 150 \text{ °C}$	Fig. 6, 9, 10	
Continuous Diode Forward Current	I <sub>s</sub>		26		V <sub>GS</sub> = -4 V, T <sub>C</sub> = 25 °C		
Diode Pulse Current	I <sub>S, pulse</sub>		132	A	$V_{GS}$ = -4 V, Pulse Width $t_p$ Limited by $T_{jmax}$		
Reverse Recovery Time	t <sub>rr</sub>	10		ns			
Reverse Recovery Charge	Q <sub>rr</sub>	206		nC	$ V_{GS} = -4 \text{ V, } I_{SD} = 17.6 \text{ A , } V_{R} = 400 \text{ V} $ $ \text{dif/dt} = 5420 \text{ A/} \mu \text{s, } T_{J} = 25 \text{ °C} $		
Peak Reverse Recovery Current	I <sub>rrm</sub>	36		A			
Reverse Recovery Time	t <sub>rr</sub>	13		ns			
Reverse Recovery Charge	Q <sub>rr</sub>	103		nC	$ \begin{cases} V_{GS} = -4 \text{ V}, I_{SD} = 17.6 \text{ A}, V_{R} = 400 \text{ V} \\ \text{dif/dt} = 1915 \text{ A/µs}, T_{J} = 25 \text{ °C} \end{cases} $		
Peak Reverse Recovery Current	I <sub>rrm</sub>	14		А			

# **Thermal Characteristics**

Parameter	Symbol	Тур.	Unit	Test Conditions	Note
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.85	96 /14		F' 01
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	40	°C/W		Fig. 21

#### **Typical Performance**

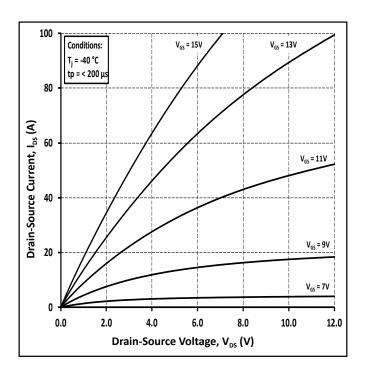


Figure 1. Output Characteristics T<sub>1</sub> = -40 °C

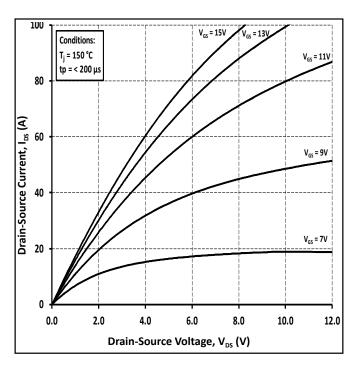
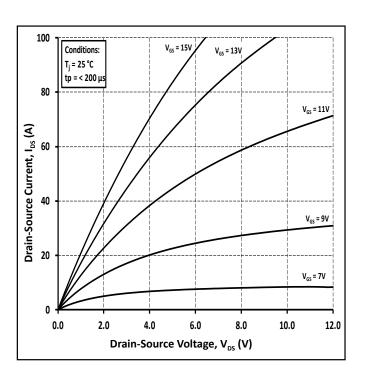


Figure 3. Output Characteristics T<sub>J</sub> = 150 °C



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Figure 2. Output Characteristics  $T_J = 25$  °C

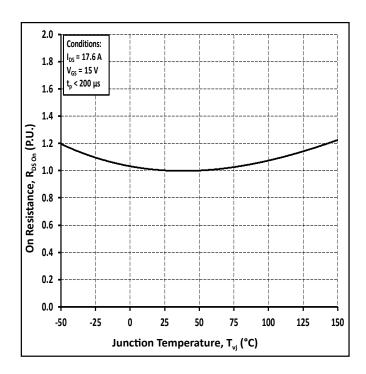


Figure 4. Normalized On-Resistance vs Temperature

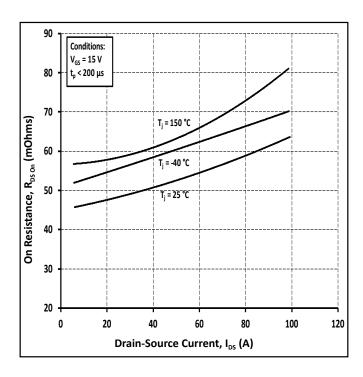


Figure 5. On-Resistance vs Drain Current for Various Temperatures

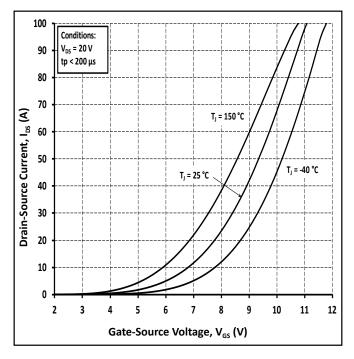


Figure 7. Transfer Characteristic for Various Junction Temperatures

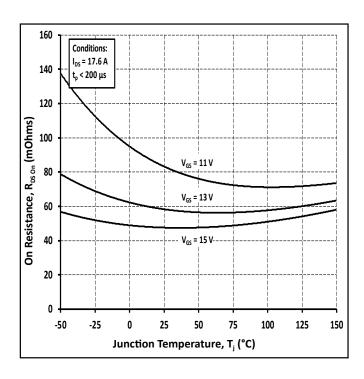


Figure 6. On-Resistance vs Temperature for Various Gate Voltage

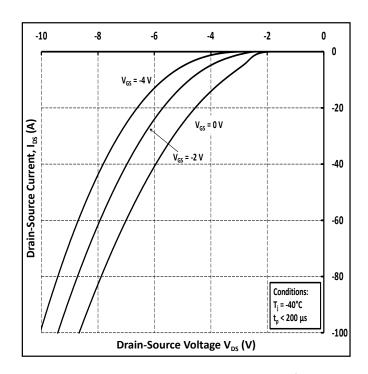


Figure 8. Body Diode Characteristic at -40 °C

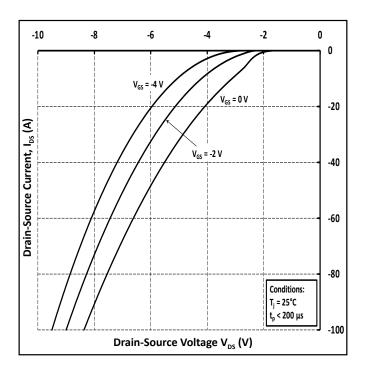


Figure 9. Body Diode Characteristic at 25 °C

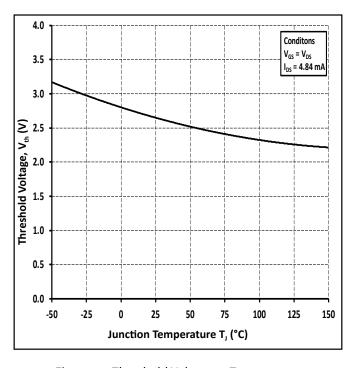


Figure 11. Threshold Voltage vs Temperature

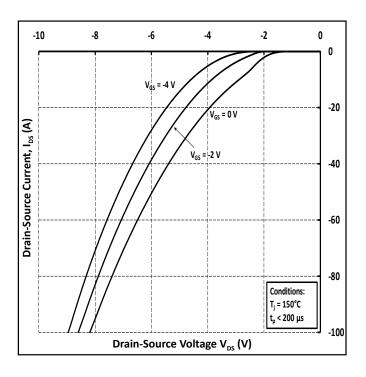


Figure 10. Body Diode Characteristic at 150 °C

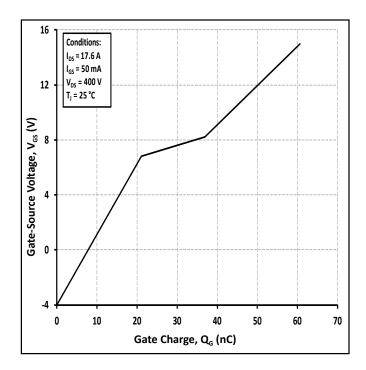


Figure 12. Gate Charge Characteristic

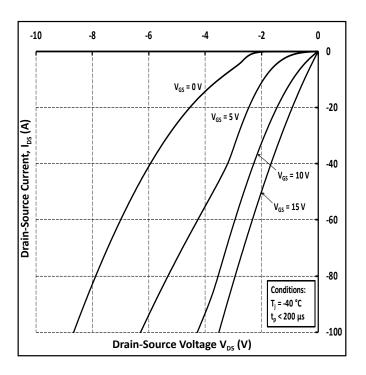


Figure 13. 3<sup>rd</sup> Quadrant Characteristic at -40 °C

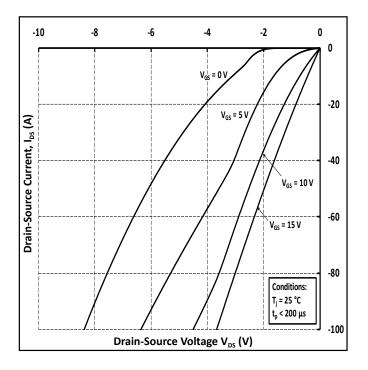


Figure 14. 3<sup>rd</sup> Quadrant Characteristic at 25 °C

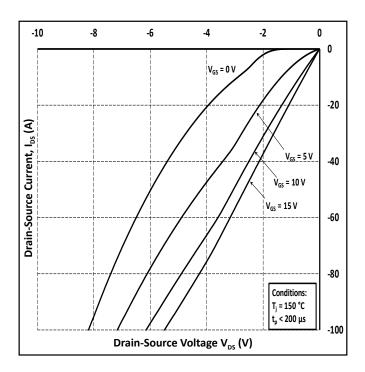


Figure 15. 3<sup>rd</sup> Quadrant Characteristic at 150 °C

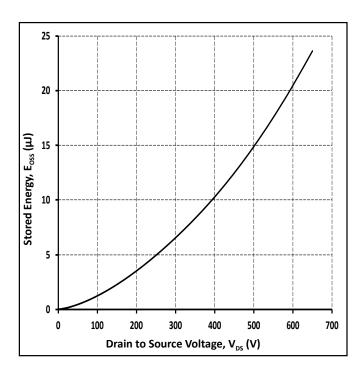


Figure 16. Output Capacitor Stored Energy

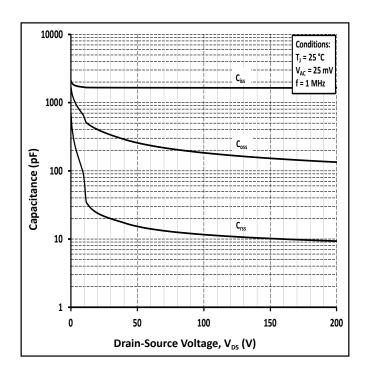


Figure 17. Capacitances vs Drain-Source Voltage (0-200 V)

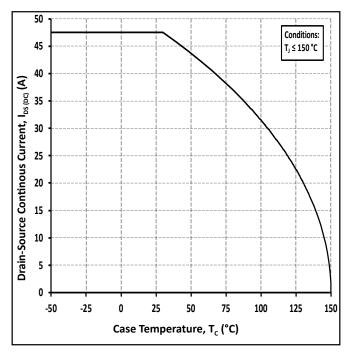


Figure 19. Continuous Drain Current Derating vs Case Temperature

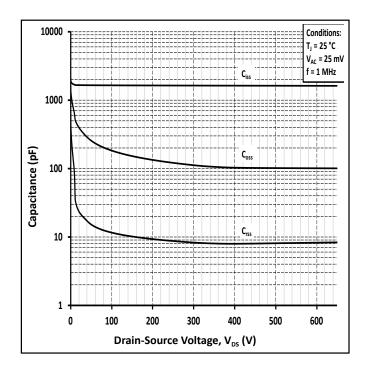


Figure 18. Capacitances vs Drain-Source Voltage (0-600 V)

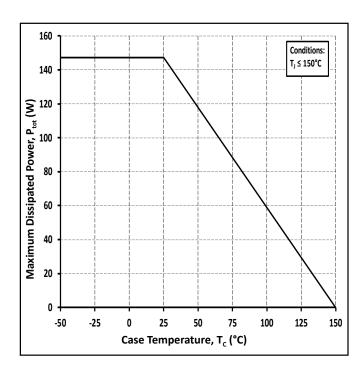


Figure 20. Maximum Power Dissipation Derating vs Case Temperature

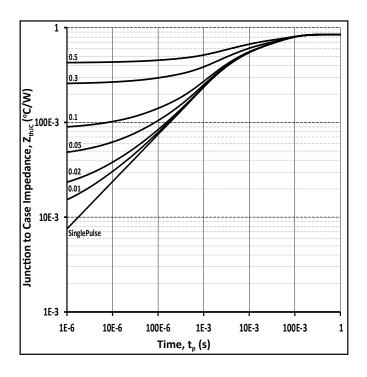


Figure 21. Transient Thermal Impedance (Junction - Case)

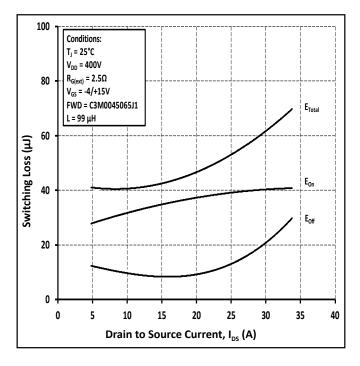


Figure 23. Clamped Inductive Switching Energy vs Drain Current ( $V_{DD}$  = 400 V)

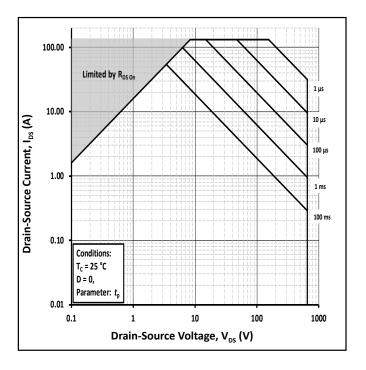


Figure 22. Safe Operating Area

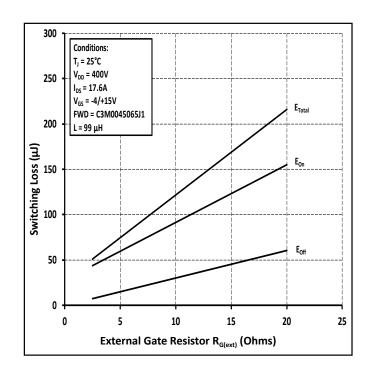


Figure 24. Clamped Inductive Switching Energy vs R<sub>G(ext)</sub>

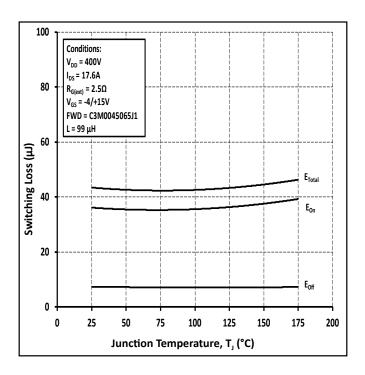


Figure 25. Clamped Inductive Switching Energy vs Temperature

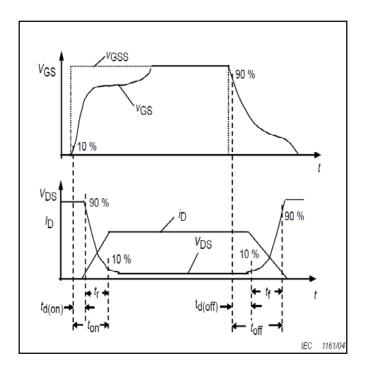


Figure 27. Switching Times Definition

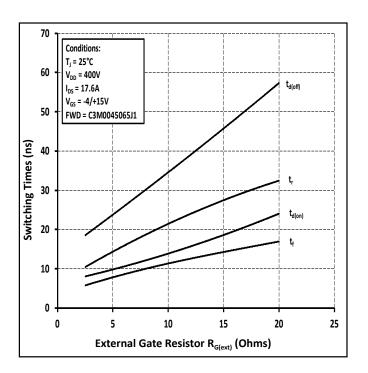


Figure 26. Switching Times vs  $R_{\text{G(ext)}}$ 

#### **Test Circuit Schematic**

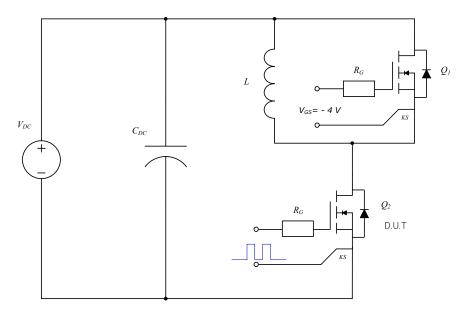
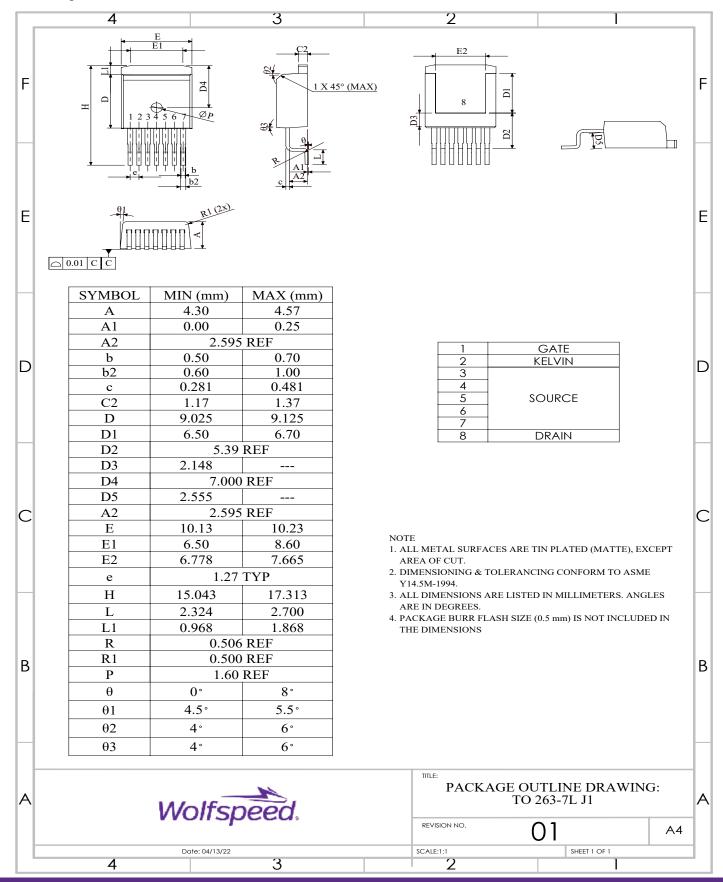


Figure 28. Clamped Inductive Switching Waveform Test Circuit

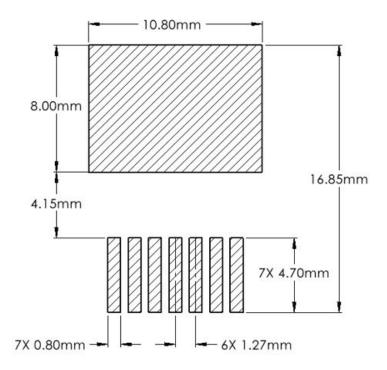
Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET body diode as shown above.

### **Package Dimensions**

Package: TO-263-7L XL



# **Recommended Solder Pad Layout**



# **Revision History**

Current Revision	Date of Release	Description of Changes
0	October-2021	N/A
1	November-2023	Updated Wolfspeed branding, package drawing, package image, solder pad layout, added revision history

#### Notes & Disclaimer

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